

10/560846

PATENT

15 DEC 2005

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Appl. No. : TBD
Applicant : Kiyoshi Fujii
Filed : Herewith
Title : "ULTRASONIC DIAGNOSTIC APPARATUS"

Confirmation No. : TBD
TC/A.U. : TBD
Examiner : TBD

International App. No. : PCT/JP2004/009594
International Flg. Date : June 30, 2004

Customer No. : 052054
Docket No. : 39088

INFORMATION DISCLOSURE STATEMENT

Mail Stop PCT
Commissioner for Patents
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Sir/Madam:

In accordance with Rule 56, applicant is aware of the publications listed in the International Search Report (ISR, copy enclosed) and in the enclosed copy of Patent Office Form 1449. Copies of the publications cited in the International Search Report are not enclosed as they were previously forwarded by the International Bureau, however, a copy of each publication cited in the specification is enclosed.

If there are any fees required by this communication, please charge such fees to our Deposit Account No. 16-0820, Order No. 39088.

Respectfully submitted,

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December 15, 2005

Express Mail Label No.: EV679907025US

Form PTO-1449	U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE	ATTY. DOCKET NO. <u>39088</u>	SERIAL NO. <u>8346</u> TBD
INFORMATION DISCLOSURE CITATION BY APPLICANT <i>(USE SEVERAL SHEETS IF NECESSARY)</i>		APPLICANT: Kiyoshi Fujii	
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U.S. PATENT DOCUMENTS

Examiner Initial		Document No.	Date	Name	Class	Subclass	Filing Date If Appropriate
	A						
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FOREIGN PATENT DOCUMENTS

		Document No.	Date	Country	Class	Subclass	Translation
	H	5-49642	03/1993	JAPAN			Cited on ISR
	I	7-178081	07/1995	JAPAN			Cited on ISR
	J	7-178089	07/1995	JAPAN			Cited on ISR
	K	7-265315	10/1995	JAPAN			Cited in Specification-English Abstract
	L	10-33529	02/1998	JAPAN			Cited on ISR
	M	10-127632	05/1998	JAPAN			Cited on ISR
	N	2000-5165	01/2000	JAPAN			Cited in Specification-English Abstract
	O	2000-107177	04/2000	JAPAN			Cited on ISR
	P	2001-321377	11/2001	JAPAN			Cited in Specification-English Abstract

OTHER REFERENCES (*Including Author, Title, Date, Pertinent Pages, Etc.*)

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